

### FEATURES

**Wide bandwidth: 1 MHz to 10 GHz**  
**High accuracy:  $\pm 1.0$  dB over temperature**  
**50 dB dynamic range up to 8 GHz**  
**Stability over temperature  $\pm 0.5$  dB**  
**Low noise measurement/controller output VOUT**  
**Pulse response time: 8/10 ns (fall/rise)**  
**Small footprint 2 mm x 3 mm CSP package**  
**Supply operation: 3.0 V to 5.5 V @ 22 mA**  
**Fabricated using high speed SiGe process**

### APPLICATIONS

**RF transmitter PA setpoint control and level monitoring**  
**Power monitoring in radiolink transmitters**  
**RSSI measurement in base stations, WLAN, WiMAX, radar**

### GENERAL DESCRIPTION

The AD8317 is a demodulating logarithmic amplifier, capable of accurately converting an RF input signal to a corresponding decibel-scaled output. It employs the progressive compression technique over a cascaded amplifier chain, each stage of which is equipped with a detector cell. The device can be used in either measurement or controller modes. The AD8317 maintains accurate log conformance for signals of 1 MHz to 8 GHz and provides useful operation to 10 GHz. The input dynamic range is typically 50 dB (re: 50  $\Omega$ ) with error less than  $\pm 1$  dB. The AD8317 has 8/10 ns response time (fall time/rise time) that enables RF burst detection to a pulse rate of beyond 50 MHz. The device provides unprecedented logarithmic intercept stability vs. ambient temperature conditions. A supply of 3.0 V to 5.5 V is required to power the device. Current consumption is typically 22 mA, and it decreases to 200  $\mu$ A when the device is disabled.

The AD8317 can be configured to provide a control voltage to a power amplifier or a measurement output from the VOUT pin. Because the output can be used for controller applications, special attention has been paid to minimize wideband noise. In this mode, the setpoint control voltage is applied to the VSET pin.

### FUNCTIONAL BLOCK DIAGRAM

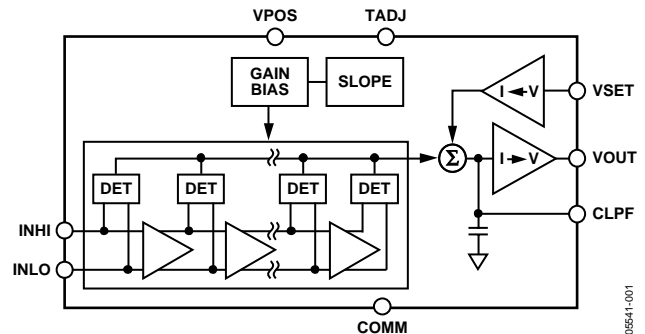


Figure 1.

The feedback loop through an RF amplifier is closed via VOUT, the output of which regulates the amplifier's output to a magnitude corresponding to  $V_{SET}$ . The AD8317 provides 0 V to ( $V_{POS} - 0.1$  V) output capability at the VOUT pin, suitable for controller applications. As a measurement device, VOUT is externally connected to VSET to produce an output voltage  $V_{OUT}$  that is a decreasing linear-in-dB function of the RF input signal amplitude.

The logarithmic slope is  $-22$  mV/dB, determined by the VSET interface. The intercept is  $+15$  dBm (re: 50  $\Omega$ , CW input) using the INHI input. These parameters are very stable against supply and temperature variations.

The AD8317 is fabricated on a SiGe bipolar IC process and is available in a 2 mm  $\times$  3 mm, 8-lead LFCSP\_VD package for an operating temperature range of  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ .

#### Rev. 0

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## REVISION HISTORY

10/05—Revision 0: Initial Version

## SPECIFICATIONS

$V_{POS} = 3\text{ V}$ ,  $C_{LPF} = 1000\text{ pF}$ ,  $T_A = 25^\circ\text{C}$ ,  $52.3\ \Omega$  termination resistor at INHI, unless otherwise noted.

**Table 1.**

Parameter	Conditions	Min	Typ	Max	Unit
<b>SIGNAL INPUT INTERFACE</b>					
Specified Frequency Range	INHI (Pin 1)	0.001		10	GHz
DC Common-Mode Voltage			$V_{POS} - 0.6$		V
<b>MEASUREMENT MODE</b>					
$f = 900\text{ MHz}$	VOU (Pin 5) shorted to VSET (Pin 4), sinusoidal input signal $R_{TADJ} = 18\text{ k}\Omega$				
Input Impedance			1500  0.33		$\Omega  \text{pF}$
$\pm 1\text{ dB}$ Dynamic Range	$T_A = +25^\circ\text{C}$ $-40^\circ\text{C} < T_A < +85^\circ\text{C}$		50 46		dB dB
Maximum Input Level	$\pm 1\text{ dB}$ error		-3		dBm
Minimum Input Level	$\pm 1\text{ dB}$ error		-53		dBm
Slope <sup>1</sup>		-25	-22	-19.5	mV/dB
Intercept <sup>1</sup>		12	15	21	dBm
Output Voltage: High Power In	$P_{IN} = -10\text{ dBm}$	0.42	0.58	0.78	V
Output Voltage: Low Power In	$P_{IN} = -40\text{ dBm}$	1.00	1.27	1.40	V
$f = 1.9\text{ GHz}$	$R_{TADJ} = 8\text{ k}\Omega$				
Input Impedance			950  0.38		$\Omega  \text{pF}$
$\pm 1\text{ dB}$ Dynamic Range	$T_A = +25^\circ\text{C}$ $-40^\circ\text{C} < T_A < +85^\circ\text{C}$		50 48		dB dB
Maximum Input Level	$\pm 1\text{ dB}$ error		-4.00		dBm
Minimum Input Level	$\pm 1\text{ dB}$ error		-54		dBm
Slope <sup>1</sup>		-25	-22	-19.5	mV/dB
Intercept <sup>1</sup>		10	14	20	dBm
Output Voltage: High Power In	$P_{IN} = -10\text{ dBm}$	0.35	0.54	0.80	V
Output Voltage: Low Power In	$P_{IN} = -35\text{ dBm}$	0.75	1.21	1.35	V
$f = 2.2\text{ GHz}$	$R_{TADJ} = 8\text{ k}\Omega$				
Input Impedance			810  0.39		$\Omega  \text{pF}$
$\pm 1\text{ dB}$ Dynamic Range	$T_A = +25^\circ\text{C}$ $-40^\circ\text{C} < T_A < +85^\circ\text{C}$		50 47		dB dB
Maximum Input Level	$\pm 1\text{ dB}$ error		-5		dBm
Minimum Input Level	$\pm 1\text{ dB}$ error		-55		dBm
Slope <sup>1</sup>			-22		mV/dB
Intercept <sup>1</sup>			14		dBm
Output Voltage: High Power In	$P_{IN} = -10\text{ dBm}$		0.53		V
Output Voltage: Low Power In	$P_{IN} = -40\text{ dBm}$		1.20		V
$f = 3.6\text{ GHz}$	$R_{TADJ} = 8\text{ k}\Omega$				
Input Impedance			300  0.33		$\Omega  \text{pF}$
$\pm 1\text{ dB}$ Dynamic Range	$T_A = +25^\circ\text{C}$ $-40^\circ\text{C} < T_A < +85^\circ\text{C}$		42 40		dB dB
Maximum Input Level	$\pm 1\text{ dB}$ error		-6		dBm
Minimum Input Level	$\pm 1\text{ dB}$ error		-48		dBm
Slope <sup>1</sup>			-22		mV/dB
Intercept <sup>1</sup>			11		dBm
Output Voltage: High Power In	$P_{IN} = -10\text{ dBm}$		0.47		V
Output Voltage: Low Power In	$P_{IN} = -40\text{ dBm}$		1.16		V

# AD8317

Parameter	Conditions	Min	Typ	Max	Unit
f = 5.8 GHz	R <sub>TADJ</sub> = 500 Ω				
Input Impedance			110  0.05		Ω  pF
±1 dB Dynamic Range	T <sub>A</sub> = +25°C		50		dB
	−40°C < T <sub>A</sub> < +85°C		48		dB
Maximum Input Level	±1 dB error		−4		dBm
Minimum Input Level	±1 dB error		−54		dBm
Slope <sup>1</sup>			−22		mV/dB
Intercept <sup>1</sup>			16		dBm
Output Voltage: High Power In	P <sub>IN</sub> = −10 dBm		0.59		V
Output Voltage: Low Power In	P <sub>IN</sub> = −40 dBm		1.27		V
f = 8.0 GHz	R <sub>TADJ</sub> = open				
Input Impedance			28  0.79		Ω  pF
±1 dB Dynamic Range	T <sub>A</sub> = +25°C		44		dB
	−40°C < T <sub>A</sub> < +85°C				dB
Maximum Input Level	±1 dB error		−2		dBm
Minimum Input Level	±1 dB error		−46		dBm
Slope <sup>2</sup>			−22		mV/dB
Intercept <sup>2</sup>			21		dBm
Output Voltage: High Power In	P <sub>IN</sub> = −10 dBm		0.70		V
Output Voltage: Low Power In	P <sub>IN</sub> = −40 dBm		1.39		V
OUTPUT INTERFACE	VOUT (Pin 5)				
Voltage Swing	V <sub>SET</sub> = 0 V, R <sub>FIN</sub> = open		V <sub>POS</sub> − 0.1		V
	V <sub>SET</sub> = 1.7 V, R <sub>FIN</sub> = open		10		mV
Output Current Drive	V <sub>SET</sub> = 0 V, R <sub>FIN</sub> = open		10		mA
Small Signal Bandwidth	R <sub>FIN</sub> = −10 dBm, from CLPF to VOUT		140		MHz
Output Noise	RF Input = 2.2 GHz, −10 dBm, f <sub>NOISE</sub> = 100 kHz, C <sub>LPF</sub> = open		90		nV/√Hz
Fall Time	Input level = no signal to −10 dBm, 90% to 10%, C <sub>LPF</sub> = 8 pF		18		ns
Fall Time	Input level = no signal to −10 dBm, 90% to 10%, C <sub>LPF</sub> = open; R <sub>OUT</sub> = 150 Ω		6		ns
Rise Time	Input level = −10 dBm to no signal, 10% to 90%, C <sub>LPF</sub> = 8 pF		20		ns
Rise Time	Input level = −10 dBm to no signal, 10% to 90%, C <sub>LPF</sub> = open, R <sub>OUT</sub> = 150 Ω		10		ns
Video Bandwidth (or Envelope Bandwidth)			50		MHz
VSET INTERFACE	VSET (Pin 4)				
Nominal Input Range	R <sub>FIN</sub> = 0 dBm, measurement mode		0.35		V
	R <sub>FIN</sub> = −50 dBm, measurement mode		1.40		V
Logarithmic Scale Factor			−45		dB/V
Input Resistance	R <sub>FIN</sub> = −20 dBm, controller mode, V <sub>SET</sub> = 1 V		40		kΩ
TADJ INTERFACE	TADJ (Pin 6)				
Input Resistance	TADJ = 0.9 V, sourcing 50 μA		13		kΩ
Disable Threshold Voltage	TADJ = open		V <sub>POS</sub> − 0.4		V

Parameter	Conditions	Min	Typ	Max	Unit
POWER INTERFACE	VPOS (Pin 7)				
Supply Voltage		3.0		5.5	V
Quiescent Current		18	22	30	mA
vs. Temperature	$-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$		60		$\mu\text{A}/^{\circ}\text{C}$
Disable Current	TADJ = VPOS		200		$\mu\text{A}$

<sup>1</sup> Slope and intercept are determined by calculating the best-fit line between the power levels of  $-40$  dBm and  $-10$  dBm at the specified input frequency.

<sup>2</sup> Slope and intercept are determined by calculating the best-fit line between the power levels of  $-34$  dBm and  $-16$  dBm at 8.0 GHz.

## ABSOLUTE MAXIMUM RATINGS

Table 2.

Parameter	Rating
Supply Voltage: $V_{POS}$	5.7 V
$V_{SET}$ Voltage	0 to $V_{POS}$
Input Power (Single-Ended, Re: 50 $\Omega$ )	12 dBm
Internal Power Dissipation	0.73
$\theta_{JA}$	55°C/W
Maximum Junction Temperature	125°C
Operating Temperature Range	−40°C to +85°C
Storage Temperature Range	−65°C to +150°C
Lead Temperature (Soldering 60 sec)	260°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

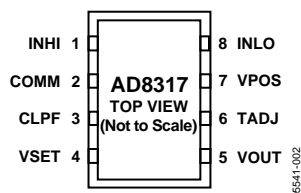


Figure 2. Pin Configuration

Table 3. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	INHI	RF Input. Nominal input range of $-50$ dBm to $0$ dBm, re: $50\ \Omega$ ; ac-coupled RF input.
2	COMM	Device Common. Connect to a low impedance ground plane.
3	CLPF	Loop Filter Capacitor. In measurement mode, this capacitor sets the pulse response time and video bandwidth. In controller mode, the capacitance on this node sets the response time of the error amplifier/integrator.
4	VSET	Setpoint Control Input for Controller Mode or Feedback Input for Measurement Mode.
5	VOUT	Measurement and Controller Output. In measurement mode, VOUT provides a decreasing linear-in dB representation of the RF input signal amplitude. In controller mode, VOUT is used to control the gain of a VGA or VVA with a positive gain sense (increasing voltage increases gain).
6	TADJ	Temperature Compensation Adjustment. Frequency-dependent temperature compensation is set by connecting a ground-referenced resistor to this pin.
7	VPOS	Positive Supply Voltage: $3.0\text{ V}$ to $5.5\text{ V}$ .
8	INLO Paddle	RF Common for INHI. AC-coupled RF common. Internally connected to COMM; solder to a low impedance ground plane.

## TYPICAL PERFORMANCE CHARACTERISTICS

$V_{POS} = 3\text{ V}$ ;  $T = 25^{\circ}\text{C}$ ,  $-40^{\circ}\text{C}$ ,  $+85^{\circ}\text{C}$ ;  $C_{LPF} = 1000\text{ pF}$ , unless otherwise noted. Colors:  $25^{\circ}\text{C} \rightarrow \text{Black}$ ;  $-40^{\circ}\text{C} \rightarrow \text{Blue}$ ;  $85^{\circ}\text{C} \rightarrow \text{Red}$ .

Error is calculated by using the best-fit line between  $P_{IN} = -40\text{ dBm}$  and  $P_{IN} = -10\text{ dBm}$  at the specified input frequency, unless otherwise noted

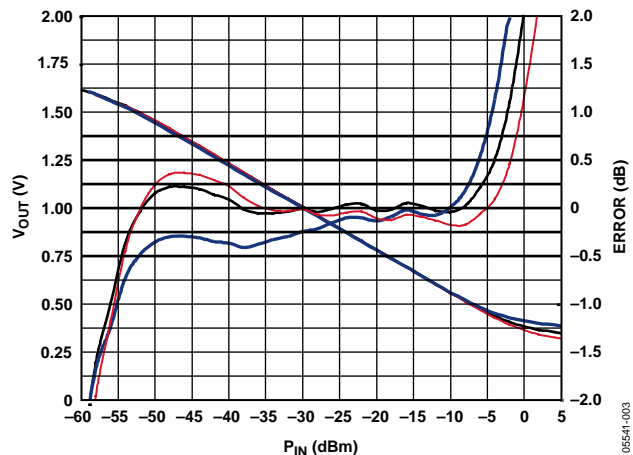


Figure 3.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 900 MHz,  $R_{TADJ} = 18\text{ k}\Omega$

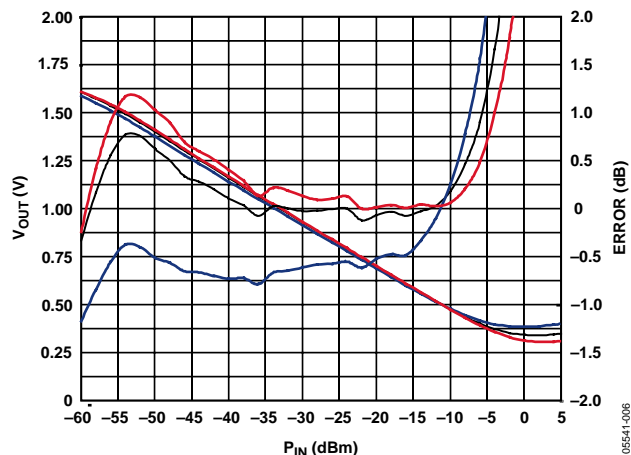


Figure 6.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 3.6 GHz,  $R_{TADJ} = 8\text{ k}\Omega$

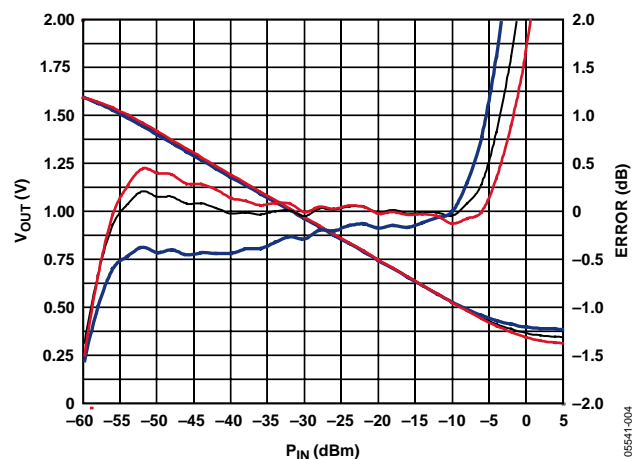


Figure 4.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 1.9 GHz,  $R_{TADJ} = 8\text{ k}\Omega$

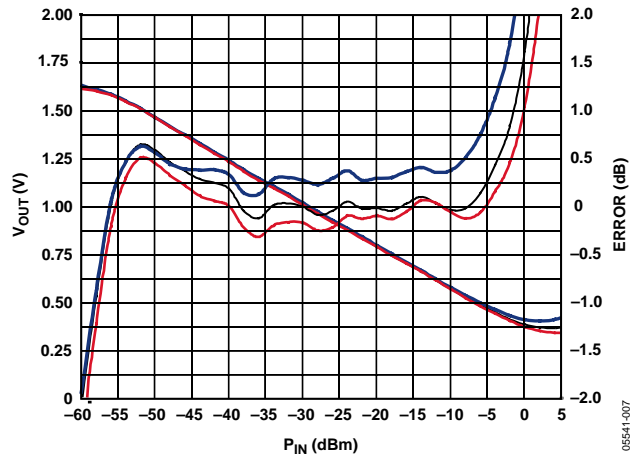


Figure 7.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 5.8 GHz,  $R_{TADJ} = 500\text{ }\Omega$

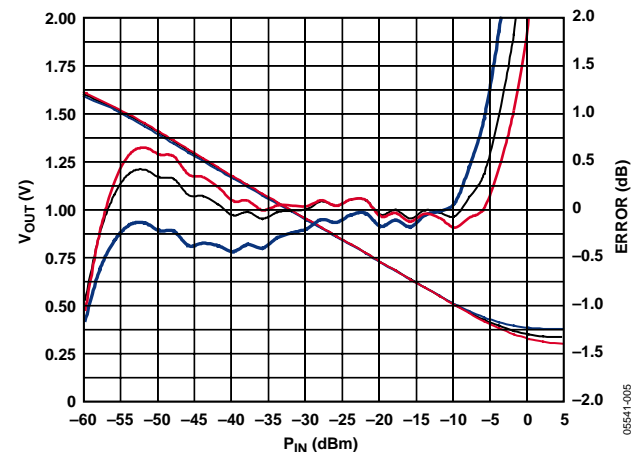


Figure 5.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 2.2 GHz,  $R_{TADJ} = 8\text{ k}\Omega$

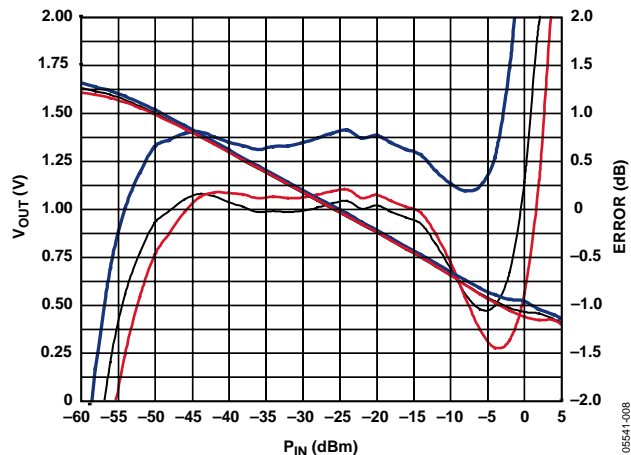


Figure 8.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 8.0 GHz,  $R_{TADJ} = \text{Open}$ , Error Calculated from  $P_{IN} = -34\text{ dBm}$  to  $P_{IN} = -16\text{ dBm}$



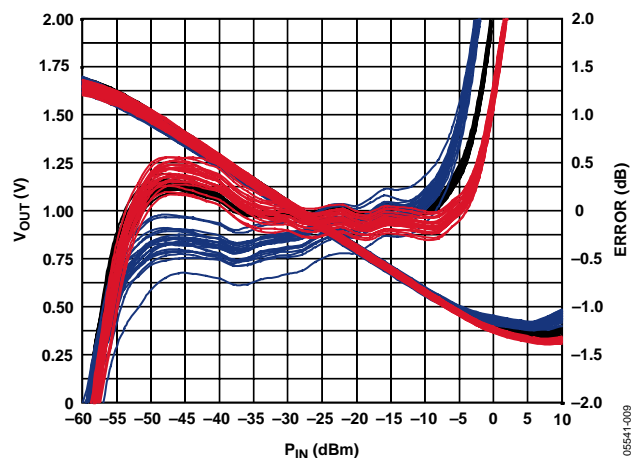


Figure 9.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 900 MHz, Multiple Devices,  $R_{TADJ} = 18\text{ k}\Omega$

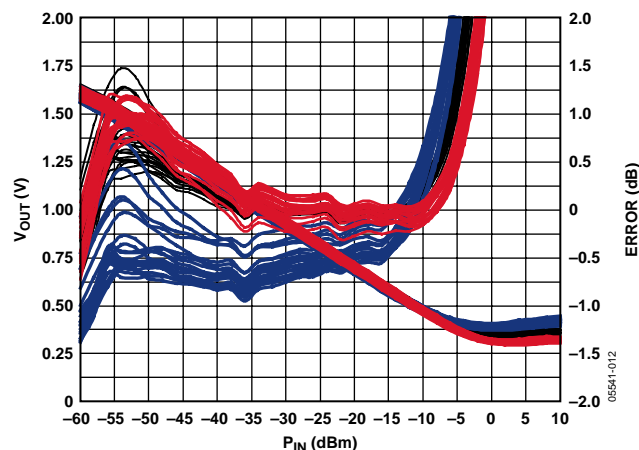


Figure 12.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 3.6 GHz, Multiple Devices,  $R_{TADJ} = 8\text{ k}\Omega$

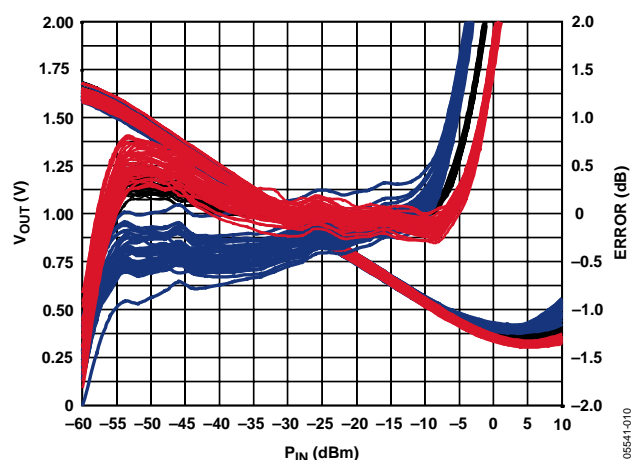


Figure 10.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 1.9 GHz, Multiple Devices,  $R_{TADJ} = 8\text{ k}\Omega$

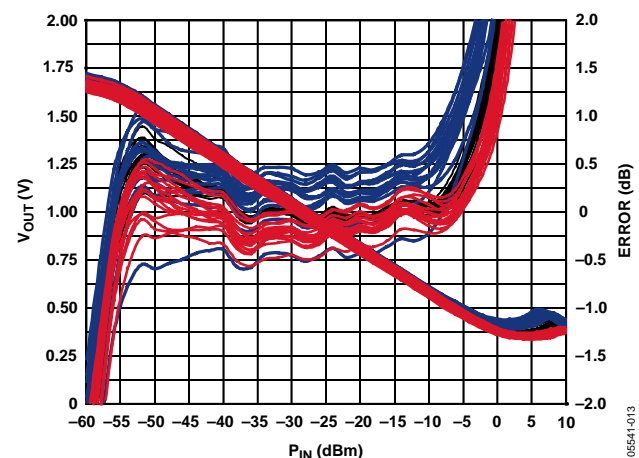


Figure 13.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 5.8 GHz, Multiple Devices,  $R_{TADJ} = 500\text{ }\Omega$

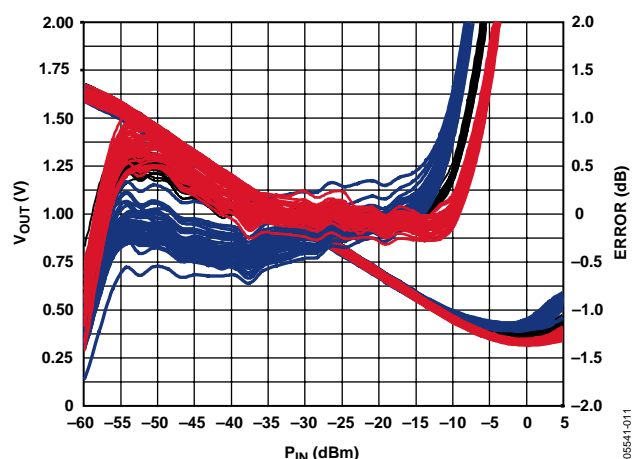


Figure 11.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 2.2 GHz, Multiple Devices,  $R_{TADJ} = 8\text{ k}\Omega$

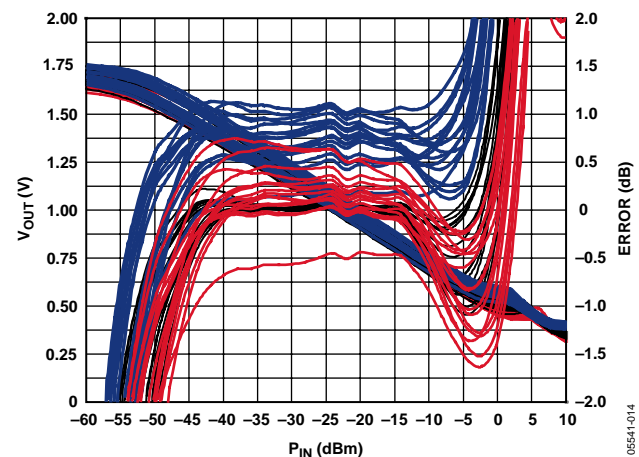


Figure 14.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 8.0 GHz, Multiple Devices,  $R_{TADJ} = \text{Open}$ , Error Calculated from  $P_{IN} = -34\text{ dBm}$  to  $P_{IN} = -16\text{ dBm}$

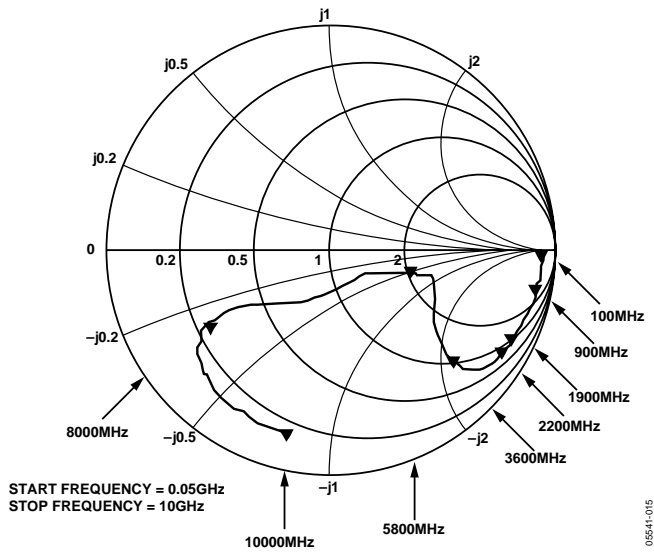


Figure 15. Input Impedance vs. Frequency; No Termination Resistor on INHI (Impedance De-Embedded to Input Pins),  $Z_0 = 50 \Omega$

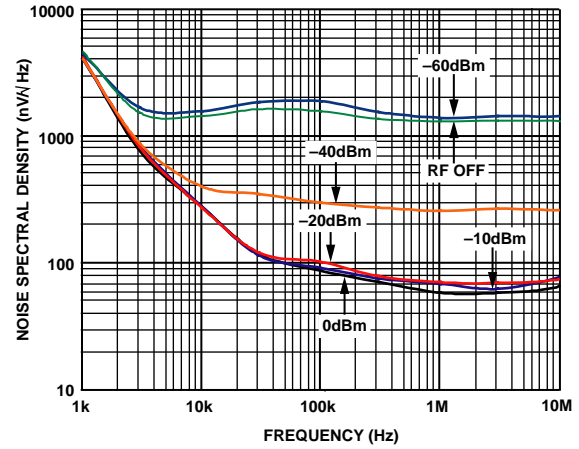


Figure 18. Noise Spectral Density of Output;  $C_{LPF} = \text{Open}$

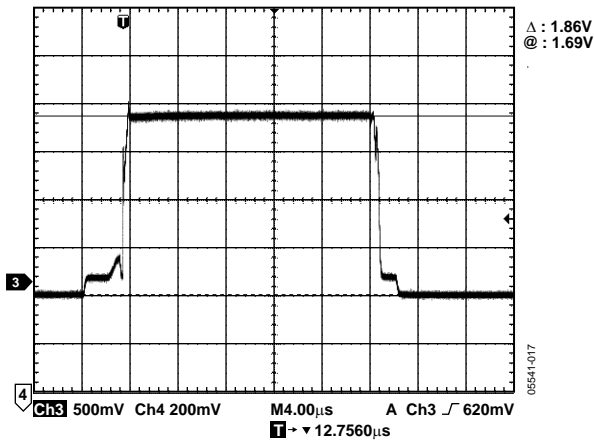


Figure 16. Power On/Off Response Time;  $V_P = 3.0 \text{ V}$ ; Input AC-Coupling Caps =  $10 \text{ pF}$ ;  $C_{LPF} = \text{Open}$

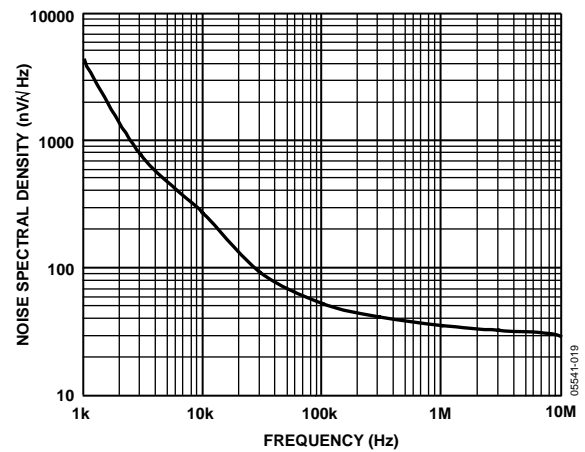


Figure 19. Noise Spectral Density of Output Buffer (from CLPF to VOUT);  $C_{LPF} = 0.1 \mu\text{F}$

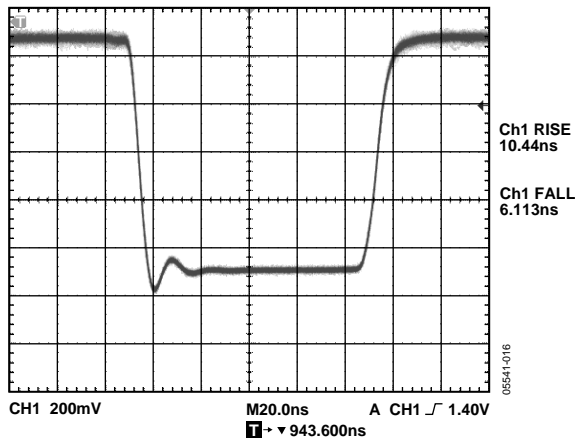


Figure 17.  $V_{OUT}$  Pulse Response Time; Pulsed RF Input  $0.1 \text{ GHz}$ ,  $-10 \text{ dBm}$ ;  $C_{LPF} = \text{Open}$ ;  $R_{LOAD} = 150 \Omega$

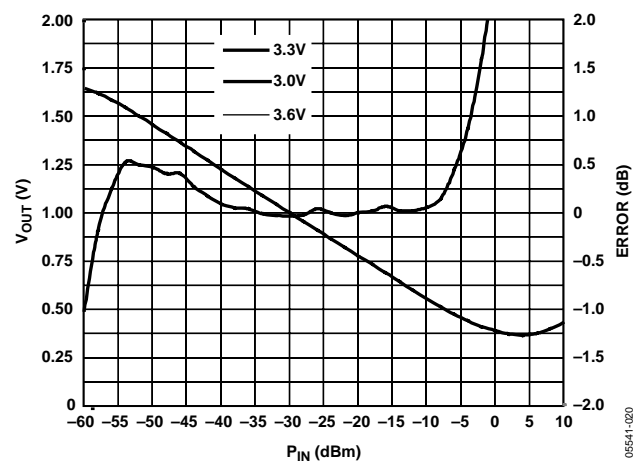


Figure 20. Output Voltage Stability vs. Supply Voltage at  $1.9 \text{ GHz}$  When  $V_{POS}$  Varies by 10%

## THEORY OF OPERATION

The AD8317 is a 6-stage demodulating logarithmic amplifier, specifically designed for use in RF measurement and power control applications at frequencies up to 10 GHz. A block diagram is shown in Figure 21. Sharing much of its design with the AD8318 logarithmic detector/controller, the AD8317 maintains tight intercept variability vs. temperature over a 50 dB range. Additional enhancements over the AD8318, such as reduced RF burst response time of 8 ns to 10 ns, 22 mA supply current, and board space requirements of only 2 mm x 3 mm, add to the low cost and high performance benefits found in the AD8317.

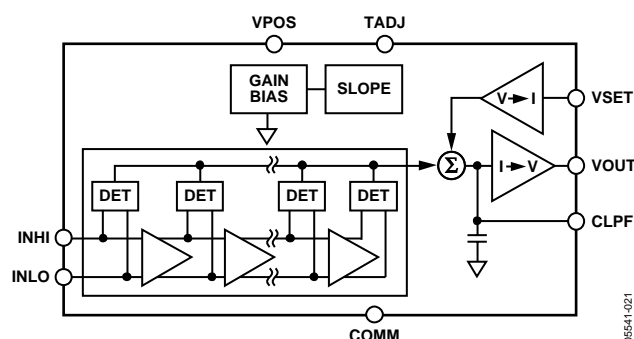


Figure 21. Block Diagram

A fully differential design, using a proprietary, high speed SiGe process, extends high frequency performance. Input INHI receives the signal with a low frequency impedance of nominally 500 Ω in parallel with 0.7 pF. The maximum input with ±1 dB log-conformance error is typically 0 dBm (re: 50 Ω). The noise spectral density referred to the input is 1.15 nV/√Hz, which is equivalent to a voltage of 118 μV rms in a 10.5 GHz bandwidth or a noise power of -66 dBm (re: 50 Ω). This noise spectral density sets the lower limit of the dynamic range. However, the low end accuracy of the AD8317 is enhanced by specially shaping the demodulating transfer characteristic to partially compensate for errors due to internal noise. The common pin, COMM, provides a quality low impedance connection to the printed circuit board (PCB) ground. The package paddle, which is internally connected to the COMM pin, should also be grounded to the PCB to reduce thermal impedance from the die to the PCB.

The logarithmic function is approximated in a piecewise fashion by six cascaded gain stages. (For a more comprehensive explanation of the logarithm approximation, please refer to the AD8307 data sheet, available at [www.analog.com](http://www.analog.com).) The cells have a nominal voltage gain of 9 dB each and a 3 dB bandwidth of 10.5 GHz. Using precision biasing, the gain is stabilized over temperature and supply variations. The overall dc gain is high, due to the cascaded nature of the gain stages. An offset compensation loop is included to correct for offsets within the cascaded cells. At the output of each of the gain stages, a square-law detector cell is used to rectify the signal.

The RF signal voltages are converted to a fluctuating differential current having an average value that increases with signal level. Along with the six gain stages and detector cells, an additional detector is included at the input of the AD8317, providing a 50 dB dynamic range in total. After the detector currents are summed and filtered, the following function is formed at the summing node:

$$I_D \times \log_{10}(V_{IN}/V_{INTERCEPT})$$

where:

$I_D$  is the internally set detector current.

$V_{IN}$  is the input signal voltage.

$V_{INTERCEPT}$  is the intercept voltage (that is, when  $V_{IN} = V_{INTERCEPT}$ , the output voltage would be 0 V, if it were capable of going to 0 V).



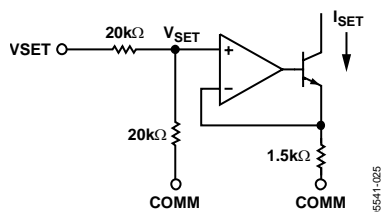


Figure 25. VSET Interface

The slope is given by  $-I_D \times 2X \times 1.5 \text{ k}\Omega = -22 \text{ mV/dB} \times x$ . For example, if a resistor divider to ground is used to generate a  $V_{SET}$  voltage of  $V_{OUT}/2$ , then  $x = 2$ . The slope is set to  $-880 \text{ V/decade}$  or  $-44 \text{ mV/dB}$ .

## TEMPERATURE COMPENSATION OF OUTPUT VOLTAGE

The primary component of the variation in  $V_{OUT}$  vs. temperature, as the input signal amplitude is held constant, is the drift of the intercept. This drift is also a weak function of the input signal frequency, so provision is made for optimization of internal temperature compensation at a given frequency by providing Pin TADJ.

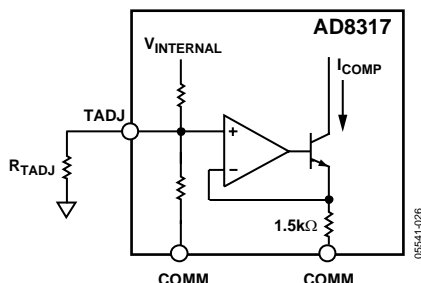


Figure 26. TADJ Interface

The Resistor  $R_{TADJ}$  is connected between this pin and ground. The value of this resistor partially determines the magnitude of an analog correction coefficient, which is used to reduce intercept drift.

The relationship between output temperature drift and frequency is not linear and cannot be easily modeled. As a result, experimentation is required to choose the correct TADJ resistor. Table 4 shows the recommended values for some commonly used frequencies.

**Table 4: Recommended  $R_{TADJ}$  Resistor Values**

Frequency	Recommended $R_{TADJ}$
50 MHz	18 kΩ
100 MHz	18 kΩ
900 MHz	18 kΩ
1.8 GHz	8 kΩ
1.9 GHz	8 kΩ
2.2 GHz	8 kΩ
3.6 GHz	8 kΩ
5.3 GHz	500 Ω
5.8 GHz	500 Ω
8 GHz	Open

## MEASUREMENT MODE

When the  $V_{OUT}$  voltage or a portion of the  $V_{OUT}$  voltage is fed back to the  $V_{SET}$  pin, the device operates in measurement mode. As seen in Figure 27, the AD8317 has an offset voltage, a negative slope, and a  $V_{OUT}$  measurement intercept at the high end of its input signal range.

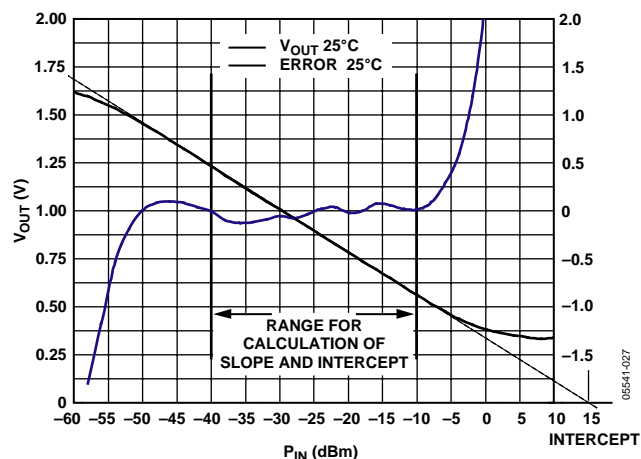


Figure 27. Typical Output Voltage vs. Input Signal

The output voltage vs. input signal voltage of the AD8317 is linear-in-dB over a multidecade range. The equation for this function is of the form

$$V_{OUT} = X \times V_{SLOPE/DEC} \times \log_{10}(V_{IN}/V_{INTERCEPT}) = \quad (1)$$

$$X \times V_{SLOPE/4B} \times 20 \times \log_{10}(V_{IN}/V_{INTERCEPT}) \quad (2)$$

where:

$X$  is the feedback factor in  $V_{SET} = V_{OUT}/X$ .

$V_{SLOPE/DEC}$  is nominally  $-440 \text{ mV/decade}$  or  $-22 \text{ mV/dB}$ .

$V_{INTERCEPT}$  is the x-axis intercept of the linear-in-dB portion of the  $V_{OUT}$  vs.  $V_{IN}$  curve (Figure 27).

$V_{INTERCEPT}$  is +2 dBV for a sinusoidal input signal.

An offset voltage,  $V_{OFFSET}$ , of 0.35 V is internally added to the detector signal, so that the minimum value for  $V_{OUT}$  is  $X \times V_{OFFSET}$ . So for  $X = 1$ , minimum  $V_{OUT}$  is 0.35 V.

The slope is very stable vs. process and temperature variation. When base-10 logarithms are used,  $V_{SLOPE/DECADE}$  represents the volts/decade. A decade corresponds to 20 dB;  $V_{SLOPE/DECADE}/20 = V_{SLOPE/4B}$  represents the slope in volts/dB.

As noted in Equation 1 and Equation 2, the  $V_{OUT}$  voltage has a *negative* slope. This is also the correct slope polarity to control the gain of many power amplifiers in a negative feedback configuration. Because both the slope and intercept vary slightly with frequency, it is recommended to refer to the Specifications section for application-specific values for slope and intercept.

Although demodulating log amps respond to input signal voltage, not input signal power, it is customary to discuss the amplitude of high frequency signals in terms of power. In this case, the characteristic impedance of the system,  $Z_0$ , must be known to convert voltages to their corresponding power levels. The following equations are used to perform this conversion:

$$P(\text{dBm}) = 10 \times \log_{10}(V_{\text{rms}}^2 / (Z_0 \times 1 \text{ mW})) \quad (3)$$

$$P(\text{dBV}) = 20 \times \log_{10}(V_{\text{rms}} / 1 \text{ V}_{\text{rms}}) \quad (4)$$

$$P(\text{dBm}) = P(\text{dBV}) - 10 \times \log_{10}(Z_0 \times 1 \text{ mW} / 1 \text{ V}_{\text{rms}}^2) \quad (5)$$

For example,  $P_{\text{INTERCEPT}}$  for a sinusoidal input signal expressed in terms of dBm (decibels referred to 1 mW), in a 50  $\Omega$  system is

$$\begin{aligned} P_{\text{INTERCEPT}}(\text{dBm}) &= P_{\text{INTERCEPT}}(\text{dBV}) - 10 \times \log_{10}(Z_0 \times 1 \text{ mW} / 1 \text{ V}_{\text{rms}}^2) \\ &= +2 \text{ dBV} - 10 \times \log_{10}(50 \times 10^{-3}) = +15 \text{ dBm} \end{aligned} \quad (6)$$

For a square wave input signal in a 200  $\Omega$  system,

$$\begin{aligned} P_{\text{INTERCEPT}} &= -1 \text{ dBV} - 10 \times \log_{10}[(200 \Omega \times 1 \text{ mW} / 1 \text{ V}_{\text{rms}}^2)] \\ &= +6 \text{ dBm} \end{aligned}$$

Further information on the intercept variation dependence upon waveform can be found in the AD8313 and AD8307 data sheets.

## SETTING THE OUTPUT SLOPE IN MEASUREMENT MODE

To operate in measurement mode, VOUT must be connected to VSET. Connecting VOUT directly to VSET yields the nominal logarithmic slope of approximately  $-22 \text{ mV/dB}$ . The output swing corresponding to the specified input range is then approximately 0.35 V to 1.7 V. The slope and output swing can be increased by placing a resistor divider between VOUT and VSET (that is, one resistor from VOUT to VSET and one resistor from VSET to ground). The input impedance of VSET is approximately 40 k $\Omega$ . Slope-setting resistors should be kept below 20 k $\Omega$  to prevent this input impedance from affecting the resulting slope. If two equal resistors are used (for example, 10 k $\Omega$ /10 k $\Omega$ ), the slope doubles to approximately  $-44 \text{ mV/dB}$ .

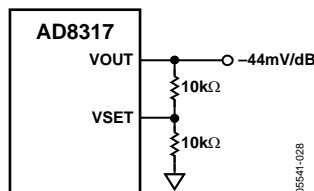


Figure 28. Increasing the Slope

## CONTROLLER MODE

The AD8317 provides a controller mode feature at the VOUT pin. Using  $V_{\text{SET}}$  for the setpoint voltage, it is possible for the AD8317 to control subsystems, such as power amplifiers (PAs), variable gain amplifiers (VGAs), or variable voltage attenuators (VVAs) that have output power that increases monotonically with respect to their gain control signal.

To operate in controller mode, the link between VSET and VOUT is broken. A setpoint voltage is applied to the VSET input, VOUT is connected to the gain control terminal of the variable gain amplifier (VGA), and the detector's RF input is connected to the output of the VGA (usually using a directional coupler and some additional attenuation). Based on the defined relationship between  $V_{\text{OUT}}$  and the RF input signal when the device is in measurement mode, the AD8317 adjusts the voltage on VOUT (VOUT is now an error amplifier output) until the level at the RF input corresponds to the applied  $V_{\text{SET}}$ . When the AD8317 operates in controller mode, there is no defined relationship between  $V_{\text{SET}}$  and  $V_{\text{OUT}}$  voltage;  $V_{\text{OUT}}$  settles to a value that results in the correct input signal level appearing at INHI/INLO.

For this output power control loop to be stable, a ground-referenced capacitor must be connected to the CLPF pin. This capacitor,  $C_{\text{FLT}}$ , integrates the error signal (in the form of a current) to set the loop bandwidth and ensure loop stability. Further details on control loop dynamics can be found in the AD8315 data sheet.

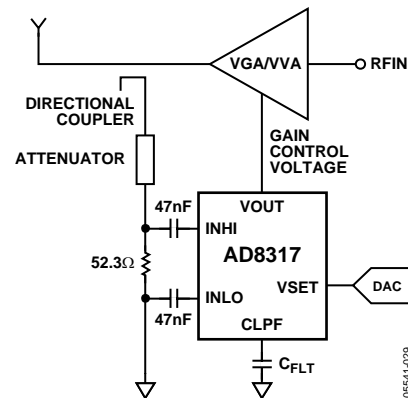


Figure 29. AD8317 Controller Mode

Decreasing  $V_{\text{SET}}$ , which corresponds to demanding a higher signal from the VGA, increases  $V_{\text{OUT}}$ . The gain control voltage of the VGA must have a positive sense. A positive control voltage to the VGA increases the gain of the device.

The basic connections for operating the AD8317 in an automatic gain control (AGC) loop with the ADL5330 are shown in Figure 30. The ADL5330 is a 10 MHz to 3 GHz variable gain amplifier. It offers a large gain control range of 60 dB with  $\pm 0.5 \text{ dB}$  gain stability. This configuration is similar to Figure 29.





# AD8317

Calibration in controller mode is similar to the method used in measurement mode. A simple two-point calibration can be done by applying two known  $V_{SET}$  voltages or DAC codes and measuring the output power from the VGA. Slope and intercept can then be calculated with the following equations:

$$Slope = (V_{SET1} - V_{SET2}) / (P_{OUT1} - P_{OUT2}) \quad (7)$$

$$Intercept = P_{OUT1} - V_{SET1} / Slope \quad (8)$$

$$V_{SETX} = Slope \times (P_{OUTX} - Intercept) \quad (9)$$

More information on the use of the ADL5330 in AGC applications can be found in the ADL5330 data sheet.

## OUTPUT FILTERING

For applications in which maximum video bandwidth and, consequently, fast rise time are desired, it is essential that the CLPF pin be left unconnected and free of any stray capacitance.

The nominal output video bandwidth of 50 MHz can be reduced by connecting a ground-referenced capacitor ( $C_{FLT}$ ) to the CLPF pin, as shown in Figure 34. This is generally done to reduce output ripple (at twice the input frequency for a symmetric input waveform such as sinusoidal signals).

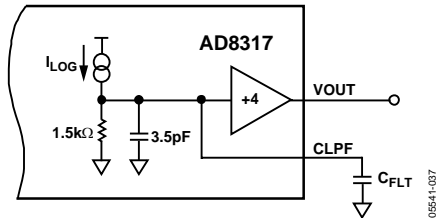


Figure 34. Lowering the Postdemodulation Bandwidth

$C_{FLT}$  is selected using the following equation:

$$C_{FLT} = \frac{1}{(\pi \times 1.5 \text{ k}\Omega \times \text{Video Bandwidth})} - 3.5 \text{ pF} \quad (10)$$

The video bandwidth should typically be set to a frequency equal to about one-tenth the minimum input frequency. This ensures that the output ripple of the demodulated log output, which is at twice the input frequency, is well filtered.

In many log amp applications, it may be necessary to lower the corner frequency of the postdemodulation filtering to achieve low output ripple while maintaining a rapid response time to changes in signal level. An example of a 4-pole active filter is shown in the AD8307 data sheet.

## OPERATION BEYOND 8 GHz

The AD8317 is specified for operation up to 8 GHz, but it provides useful measurement accuracy over a reduced dynamic range of up to 10 GHz. Figure 35 shows the performance of the AD8317 over temperature at 10 GHz when the device is configured as shown in Figure 22. Dynamic range is reduced at this frequency, but the AD8317 does provide 30 dB of measurement range within  $\pm 3$  dB of linearity error.

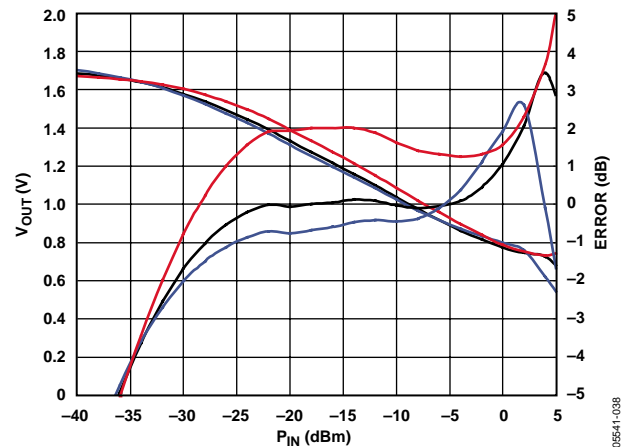


Figure 35.  $V_{OUT}$  and Log Conformance vs. Input Amplitude at 10.0 GHz, Multiple Devices,  $R_{TADJ}$  = Open,  $C_{LPF}$  = 1000 pF

Implementing an impedance match for frequencies beyond 8 GHz can improve the sensitivity of the AD8317 and measurement range.

Operation beyond 10 GHz is possible, but part-to-part variation, most notably in the intercept, becomes significant.



## EVALUATION BOARD

Table 5. Evaluation Board (Rev. A) Configuration Options

Component	Function	Default Conditions
VPOS, GND	Supply and Ground Connections.	Not applicable
R1, C1, C2	Input Interface. The 52.3 $\Omega$ resistor in position R1 combines with the AD8317's internal input impedance to give a broadband input impedance of about 50 $\Omega$ . Capacitor C1 and Capacitor C2 are dc-blocking capacitors. A reactive impedance match can be implemented by replacing R1 with an inductor and C1 and C2 with appropriately valued capacitors.	R1 = 52.3 $\Omega$ (Size 0402) C1 = 47 nF (Size 0402) C2 = 47 nF (Size 0402)
R5, R7	Temperature Compensation Interface. The internal temperature compensation network is optimized for input signals up to 3.6 GHz when R7 is 10 k $\Omega$ . This circuit can be adjusted to optimize performance for other input frequencies by changing the value of the resistor in position R7. See Table 4 for specific T <sub>ADJ</sub> resistor values.	R5 = 200 $\Omega$ (Size 0402) R7 = open (Size 0402)
R2, R3, R4, R6, RL, CL	Output Interface—Measurement Mode. In measurement mode, a portion of the output voltage is fed back to Pin VSET via R2. The magnitude of the slope of the VOUT output voltage response can be increased by reducing the portion of V <sub>OUT</sub> that is fed back to VSET. R6 can be used as a back-terminating resistor or as part of a single-pole, low-pass filter.	R2 = 0 $\Omega$ (Size 0402) R3 = open (Size 0402) R4 = open (Size 0402) R6 = 1 k $\Omega$ (Size 0402) RL = CL = open (Size 0402)
R2, R3	Output Interface—Controller Mode. In this mode, R2 must be open. In controller mode, the AD8317 can control the gain of an external component. A setpoint voltage is applied to Pin VSET, the value of which corresponds to the desired RF input signal level applied to the AD8317 RF input. A sample of the RF output signal from this variable-gain component is selected, typically via a directional coupler, and applied to AD8317 RF input. The voltage at Pin VOUT is applied to the gain control of the variable gain element. A control voltage is applied to Pin VSET. The magnitude of the control voltage can optionally be attenuated via the voltage divider comprising R2 and R3, or a capacitor can be installed in position R3 to form a low-pass filter along with R2.	R2 = open (Size 0402) R3 = open (Size 0402)
C4, C5,	Power Supply Decoupling. The nominal supply decoupling consists of a 100 pF filter capacitor placed physically close to the AD8317 and a 0.1 $\mu$ F capacitor placed nearer to the power supply input pin.	C5 = 100 pF (Size 0402) C4 = 0.1 $\mu$ F (Size 0603)
C3	Filter Capacitor. The low-pass corner frequency of the circuit that drives Pin VOUT can be lowered by placing a capacitor between CLPF and ground. Increasing this capacitor increases the overall rise/fall time of the AD8317 for pulsed input signals. See the Output Filtering section for more details.	C3 = 8.2 pF (Size 0402)



Figure 36. Evaluation Board Schematic



Figure 37. Component Side Layout



Figure 38. Component Side Silkscreen

## OUTLINE DIMENSIONS

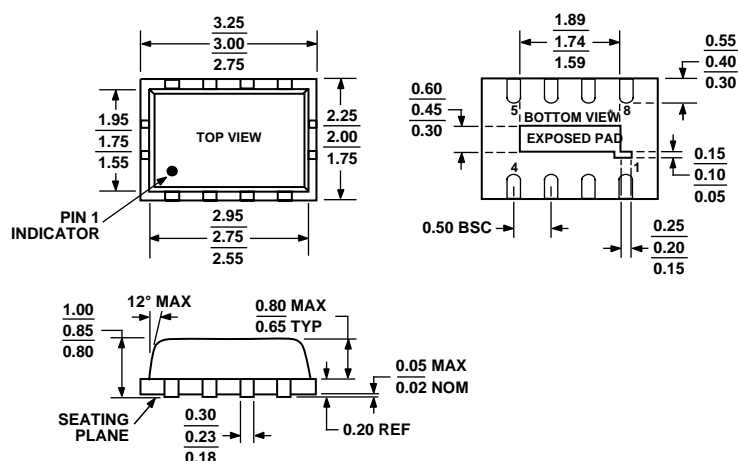


Figure 39. 8-Lead Lead Frame Chip Scale Package [LFCSP\_VD]  
 2 mm x 3 mm Body, Very Thin, Dual Lead  
 (CP-8-1)  
 Dimensions shown in millimeters

## ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option	Branding
AD8317ACPZ-R7 <sup>1</sup>	–40°C to +85°C	8-Lead LFCSP_VD	CP-8-1	Q1
AD8317ACPZ-R2 <sup>1</sup>	–40°C to +85°C	8-Lead LFCSP_VD	CP-8-1	Q1
AD8317ACPZ-WP <sup>1, 2</sup>	–40°C to +85°C	8-Lead LFCSP_VD	CP-8-1	Q1
AD8317-EVAL		Evaluation Board		

<sup>1</sup> Z = Pb-free part.

<sup>2</sup> WP = waffle pack.

**AD8317**

## NOTES